

# INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)



Docket Number (Optional)

66457-140

Application Number

09/821,792

Applicant(s)

Alain WACKER

Filing Date

March 30, 2001

Group Art Unit

2812

RECEIVED

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)
18		4,748,507	5/1988	GURAL			
18		4,581,649	4/1986	MOROKAWA			

## FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
18		9325043	12/1993	WIPO			✓	

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

18		Patent Abstracts of Japan, Vol. 1998, No. 6, 30 April 1998 of JP 10 038961, 13 Feb. 1998, entitled "Detecting Apparatus For Defect of Pixel in Two-Dimensional Solid-State Image Sensing Device."
18		Patent Abstracts of Japan, Vol. 13, No. 272, 22 June 1989 of JP 01 062977, 9 March 1989, entitled "Solid-State Image Pickup Device."

EXAMINER

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DATE CONSIDERED

8/20/04

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.